	L #	Hits	Search Text	DBs
1	L1	2		US- PGPUB; USPAT; EPO; JPO; DERWEN T; IBM_TD B
2	L2	12	("4083254" "4322979" "4490618" "4681451" "4865453" "4891584" "4941753" "4992728" "5018865" "5028132" "5065103" "5125740").PN.	US- PGPUB; USPAT; USOCR
3	L3	18958	(measur\$3 or detect\$3 or determin\$3) near2 gap	US- PGPUB; USPAT; USOCR
4	L4	0	2 and 3	US- PGPUB; USPAT; USOCR
5	L5	11	2 and distance	US- PGPUB; USPAT; USOCR
6	L6	10	("5239183").URPN.	USPAT
7	L 7	125	3 same mask same (substrate or wafer)	US- PGPUB; USPAT; EPO; JPO; DERWEN T; IBM_TD B

	L #	Hits	Search Text	DBs
8	L8	107	7 and distance	US- PGPUB; USPAT; EPO; JPO; DERWEN T; IBM_TD B
9	L9		distance near3 (measur\$5 or detect\$3 or determin\$3)	US- PGPUB; USPAT; EPO; JPO; DERWEN T; IBM_TD B
10	L10	62	7 and 9	US- PGPUB; USPAT; EPO; JPO; DERWEN T; IBM_TD B
11	L11	1100		US- PGPUB; USPAT; EPO; JPO; DERWEN T; IBM_TD B

	L #	Hits	Search Text	DBs
12	L12	20	11 same 7	US- PGPUB; USPAT; EPO; JPO; DERWEN T; IBM_TD B
13	L14	2	kwak near changsoo	US- PGPUB; USPAT; EPO; JPO; DERWEN T; IBM_TD B